

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/574,682	BOHNE ET AL.	
Examiner	Art Unit	
Eileen P. Morgan	3723	

	SEARCHED Subclass Date Examiner 456 354					
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Class	Subclass	Date	Examiner			
451	456 354 356 357					
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		8/1/2010	EPM			

INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
East	8/1/2010	EPM	